

December 2011

FDD86113LZ

N-Channel PowerTrench[®] MOSFET 100 V, 5.5 A, 104 m Ω

Features

- Max $r_{DS(on)} = 104 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 4.2 \text{ A}$
- Max $r_{DS(on)}$ = 156 m Ω at V_{GS} = 4.5 V, I_D = 3.4 A
- HBM ESD protection level > 6 kV typical (Note 4)
- High performance trench technology for extremely low rDS(on)
- High power and current handling capability in a widely used surface mount package
- 100% UIL Tested
- RoHS Compliant

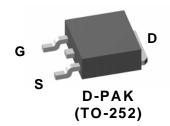


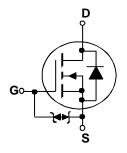
General Description

This N-Channel logic Level MOSFETs are produced using Fairchild Semiconductor's advanced Power Trench® process that has been special tailored to minimize the on-state resistance and yet maintain superior switching performance. G-S zener has been added to enhance ESD voltage level.

Application

■ DC-DC conversion





MOSFET Maximum Ratings T_C = 25 °C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|-----------------------------------|----------------------------------------------|----------------------------------|-------------|-------|
| V _{DS} | Drain to Source Voltage | | 100 | V |
| V_{GS} | Gate to Source Voltage | | ±20 | V |
| | Drain Current -Continuous(Package limited |) T _C = 25 °C | 5.5 | |
| | -Continuous (Silicon limited) | T _C = 25 °C | 11.8 | ۸ |
| ID | -Continuous | T _A = 25 °C (Note 1a) | 4.2 | A |
| | -Pulsed | | 15 | |
| E _{AS} | Single Pulse Avalanche Energy (Note | | 12 | mJ |
| Б | Power Dissipation | T _C = 25 °C | 29 | W |
| P_{D} | Power Dissipation | $T_A = 25 ^{\circ}C$ (Note 1a) | 3.1 | VV |
| T _J , T _{STG} | Operating and Storage Junction Temperature I | Range | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | (Note 1) | 4.3 | °C/W |
|-----------------|-----------------------------------------|-----------|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1a) | 9 | C/VV |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|------------|---------------|-----------|------------|------------|
| FDD86113LZ | FDD86113LZ | D-PAK(TO-252) | 13 " | 12 mm | 2500 units |

Electrical Characteristics T_J = 25 °C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|----------------------------------------|-------------------------------------------|---------------------------------------------------|-----|-----|-----|-------|
| Off Chara | acteristics | | | | | |
| BV_DSS | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 100 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | I_D = 250 μ A, referenced to 25 °C | | 72 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 80 V, V _{GS} = 0 V | | | 1 | μΑ |
| I_{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ±10 | μΑ |

On Characteristics

| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_{D} = 250 \mu A$ | 1 | 1.5 | 3 | V |
|----------------------------------------|-------------------------------------------------------------|--------------------------------------------------------------------------|---|-----|-----|-------|
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | I_D = 250 μ A, referenced to 25 °C | | -5 | | mV/°C |
| | | $V_{GS} = 10 \text{ V}, I_D = 4.2 \text{ A}$ | | 87 | 104 | |
| r _{DS(on)} | Static Drain to Source On Resistance | $V_{GS} = 4.5 \text{ V}, I_D = 3.4 \text{ A}$ | | 116 | 156 | mΩ |
| , , | | $V_{GS} = 10 \text{ V}, I_D = 4.2 \text{ A}, T_J = 125 ^{\circ}\text{C}$ | | 142 | 170 | |
| 9 _{FS} | Forward Transconductance | $V_{DS} = 5 \text{ V}, I_{D} = 4.2 \text{ A}$ | | 9 | | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | V 50 V V 0 V | 213 | 285 | pF |
|------------------|------------------------------|------------------------------------------------------------|-----|-----|----|
| Coss | Output Capacitance | V _{DS} = 50 V, V _{GS} = 0 V, f = 1MHz | 55 | 75 | pF |
| C _{rss} | Reverse Transfer Capacitance | - | 2.4 | 5 | pF |
| R_g | Gate Resistance | | 1.4 | | Ω |

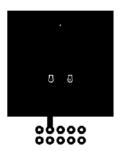
Switching Characteristics

| t _{d(on)} | Turn-On Delay Time | | | | 3.6 | 10 | ns |
|---------------------|-------------------------------|--------------------------------------------|-------------------------------------------------|--|-----|----|----|
| t _r | Rise Time | $V_{DD} = 50 \text{ V}, I_{D} = 4.2$ | V _{DD} = 50 V, I _D = 4.2 A, | | 1.3 | 10 | ns |
| t _{d(off)} | Turn-Off Delay Time | V _{GS} = 10 V, R _{GEN} = | = 6 Ω | | 9.7 | 20 | ns |
| t _f | Fall Time | | | | 1.6 | 10 | ns |
| $Q_{g(TOT)}$ | Total Gate Charge | V _{GS} = 0 V to 10 V | | | 3.7 | 6 | nC |
| $Q_{g(TOT)}$ | Total Gate Charge | $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ | $V_{DD} = 50 \text{ V},$ | | 1.9 | 3 | |
| Q_{gs} | Gate to Source Charge | | $I_D = 4.2 \text{ A}$ | | 0.6 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | | | | 0.7 | | nC |

Drain-Source Diode Characteristics

| V | Vob 12001ce to Diain Diode Forward voltage 1 | $V_{GS} = 0 \text{ V}, I_{S} = 4.2 \text{ A}$ | (Note 2) | 0.88 | 1.3 | V |
|-----------------|----------------------------------------------|-----------------------------------------------|----------|------|-----|----|
| V SD | | $V_{GS} = 0 \text{ V}, I_{S} = 1.7 \text{ A}$ | (Note 2) | 0.80 | 1.2 | v |
| t _{rr} | Reverse Recovery Time | -I _F = 4.2 A, di/dt = 100 A/μs | | 31 | 49 | ns |
| Q _{rr} | Reverse Recovery Charge | | | 20 | 33 | nC |

^{1.} $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 40 °C/W when mounted on a 1 in² pad of 2 oz copper



b) 96 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0 %.
 3. Starting T_J = 25 °C, L = 1 mH, I_{AS} = 5 A, V_{DD} = 90 V, V_{GS} = 10 V.
 4. The diode connected between gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25 °C unless otherwise noted

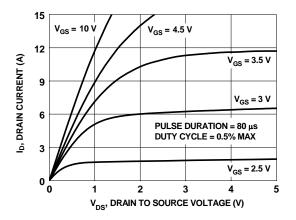


Figure 1. On-Region Characteristics

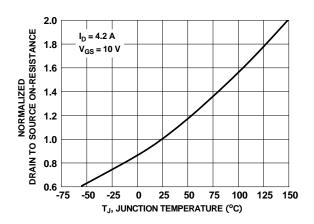


Figure 3. Normalized On-Resistance vs Junction Temperature

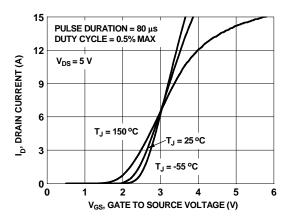


Figure 5. Transfer Characteristics

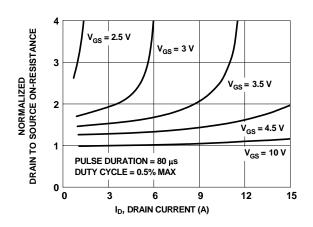


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

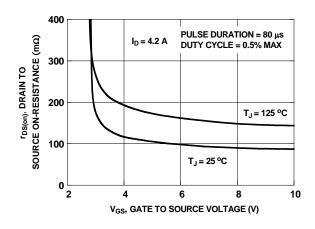


Figure 4. On-Resistance vs Gate to Source Voltage

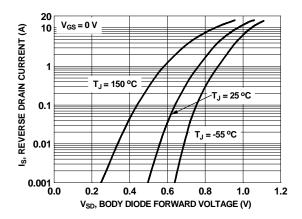


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

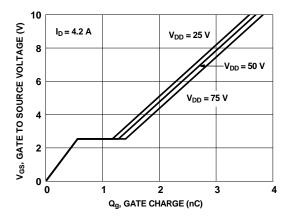


Figure 7. Gate Charge Characteristics

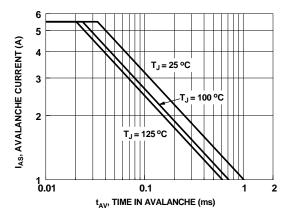


Figure 9. Unclamped Inductive Switching Capability

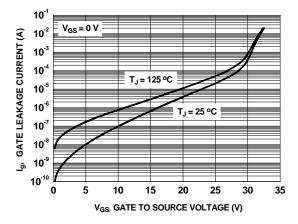


Figure 11. Gate Leakage Current vs Gate to Source Voltage

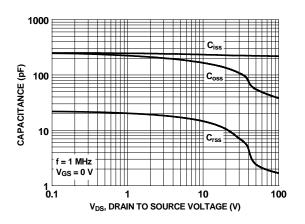


Figure 8. Capacitance vs Drain to Source Voltage

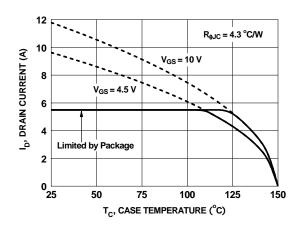


Figure 10. Maximum Continuous Drain Current vs Case Temperature

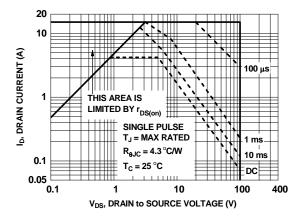


Figure 12. Forward Bias Safe Operating Area

Typical Characteristics $T_J = 25$ °C unless otherwise noted

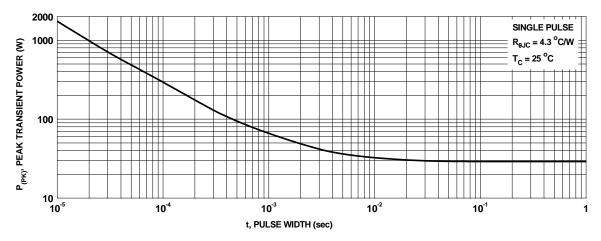


Figure 13. Single Pulse Maximum Power Dissipation

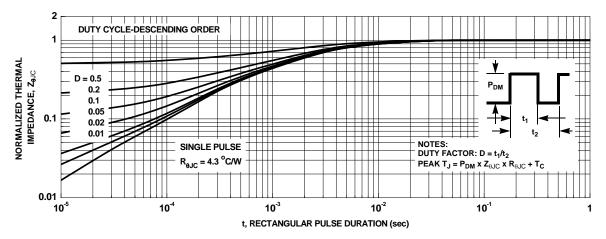


Figure 14. Junction-to-Case Transient Thermal Response Curve





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Rev. 160